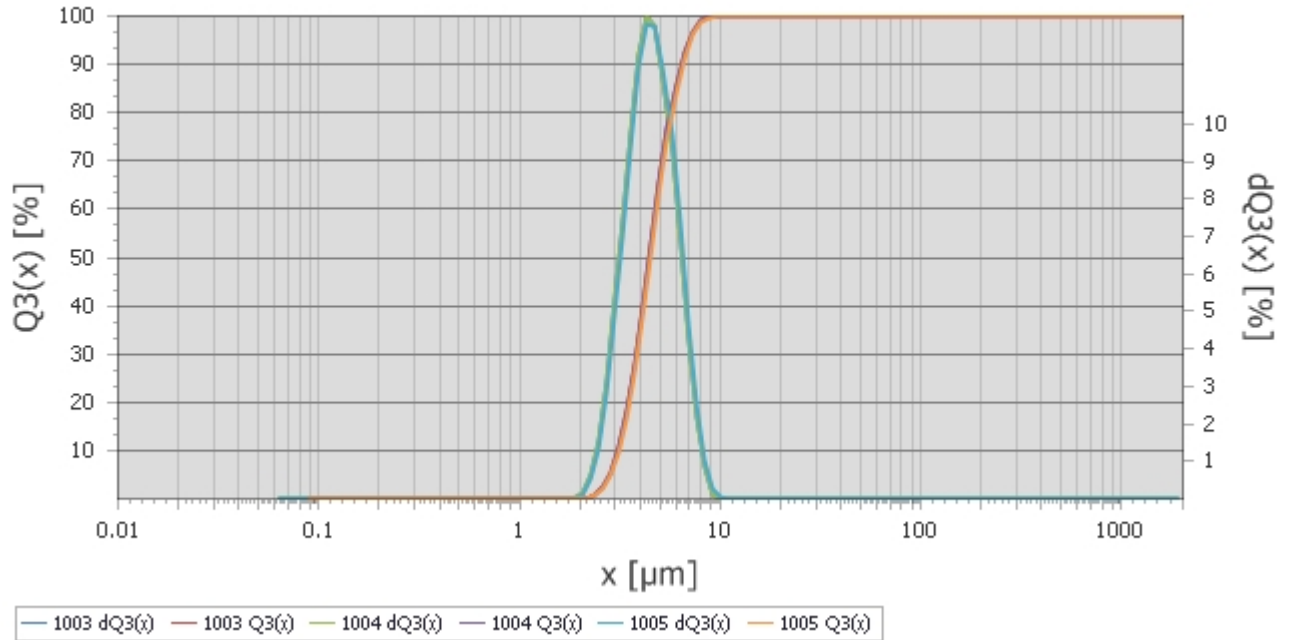


Notes

Overview of all Measurements

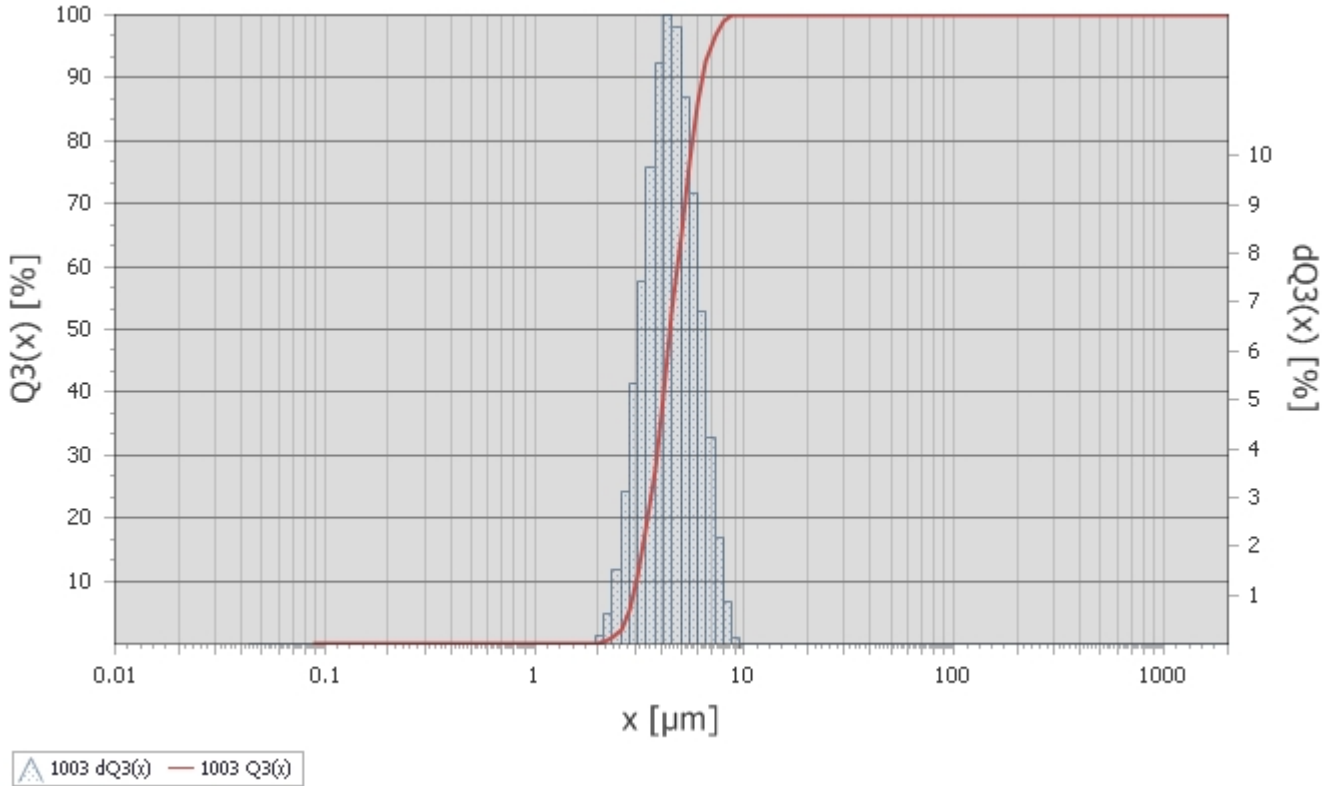


Q3(x) [%]	x [μm]	CV [%]	M1003	M1004	M1005
10	3.1	0.8	3.1	3.1	3.1
50	4.5	0.8	4.4	4.4	4.5
90	6.4	0.8	6.4	6.4	6.5

ANALYSETTE 22 MicroTec plus

Meas.No. 1003 **Date** Tuesday, 10 February 2015 01:26 PM
Attr. 1 **Attr. 2**
Attr. 3 **Attr. 4**

Calculation Mie **TradeOff** broad (1000.0)
Refractive Index 1.59 **Absorption Index** 0
Scans Fine 100 **Scans Coarse** 100 **Channels** 108 **Beam Obscuration** 16.0 %
Meas. Range 0.08 [µm] - 2000.00 [µm] **Pump** 60 % **Ultrasonics** 100 %



Mode 4.41 µm

Span (d90-d10)/d50 0.73

D[4,3] 4.6 µm

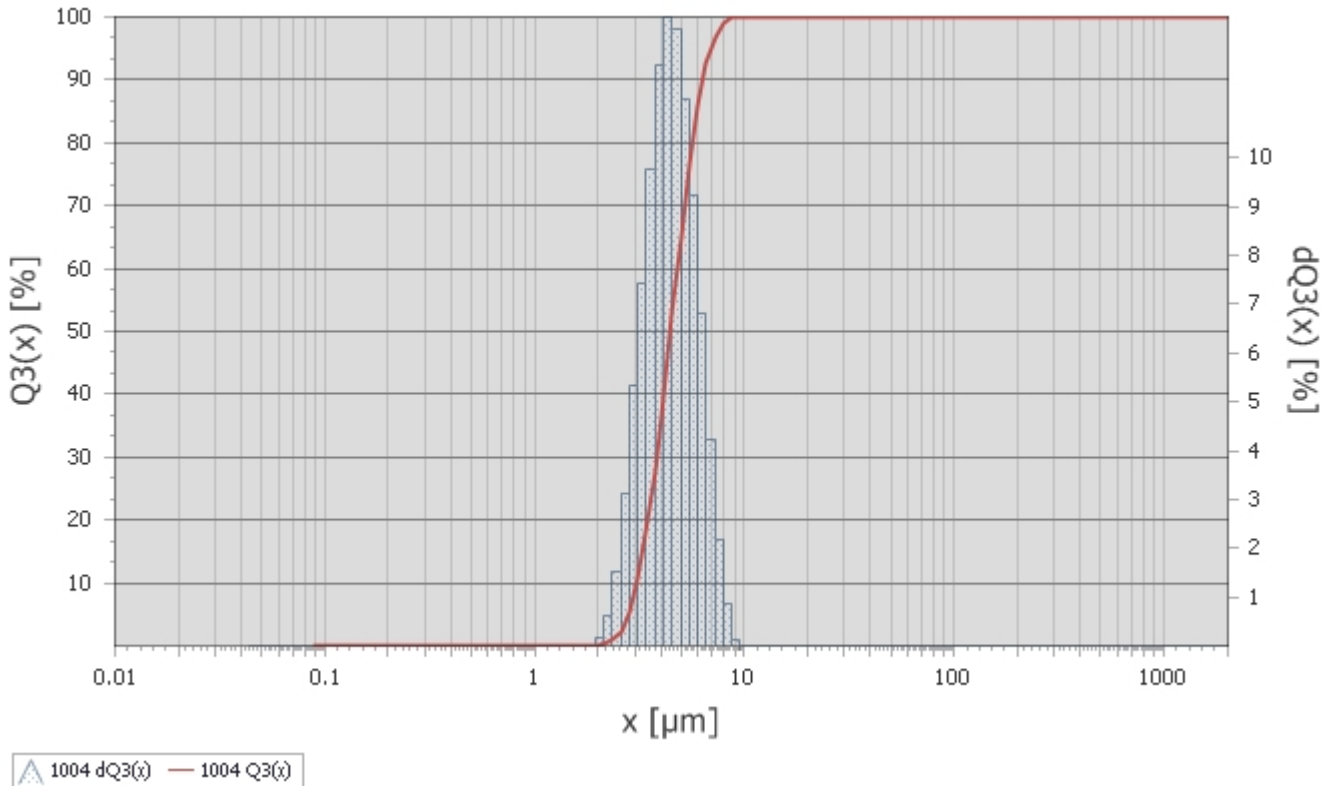
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Q3(x) [%]	x [µm]
5	2.8
10	3.1
25	3.6
50	4.4
75	5.4
90	6.4
95	7
99	7.9

ANALYSETTE 22 MicroTec plus

Meas.No. 1004 **Date** Tuesday, 10 February 2015 01:27 PM
Attr. 1 **Attr. 2**
Attr. 3 **Attr. 4**

Calculation Mie **TradeOff** broad (1000.0)
Refractive Index 1.59 **Absorption Index** 0
Scans Fine 100 **Scans Coarse** 100 **Channels** 108 **Beam Obscuration** 15.0 %
Meas. Range 0.08 [µm] - 2000.00 [µm] **Pump** 60 % **Ultrasonics** 100 %



Mode 4.41 µm **Span** (d90-d10)/d50 0.73 **D[4,3]** 4.6 µm

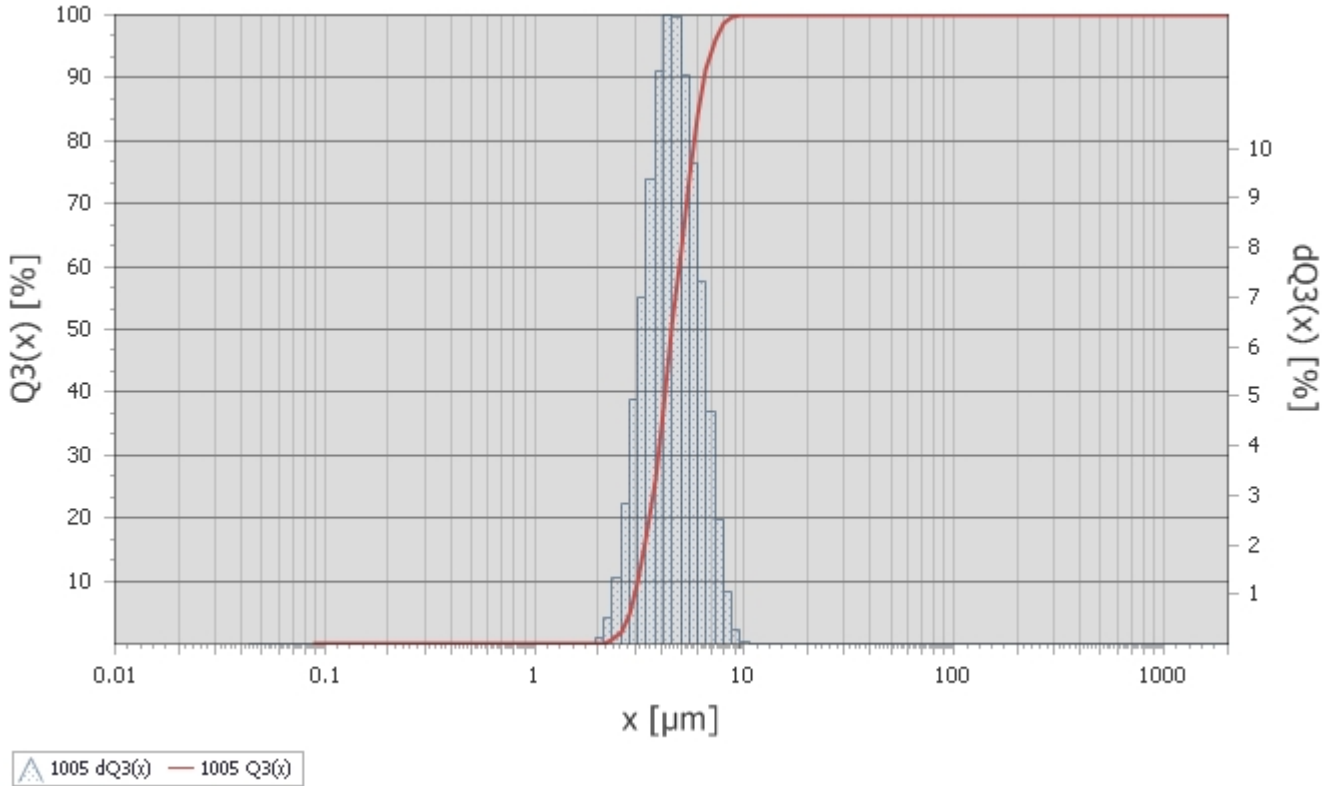


Q3(x) [%]	x [µm]
5	2.8
10	3.1
25	3.6
50	4.4
75	5.4
90	6.4
95	7
99	7.9

ANALYSETTE 22 MicroTec plus

Meas.No. 1005 **Date** Tuesday, 10 February 2015 01:27 PM
Attr. 1 **Attr. 2**
Attr. 3 **Attr. 4**

Calculation Mie **TradeOff** broad (1000.0)
Refractive Index 1.59 **Absorption Index** 0
Scans Fine 100 **Scans Coarse** 100 **Channels** 108 **Beam Obscuration** 13.0 %
Meas. Range 0.08 [µm] - 2000.00 [µm] **Pump** 60 % **Ultrasonics** 100 %



Mode 4.56 µm **Span** (d90-d10)/d50 0.74 **D[4,3]** 4.7 µm



Q3(x) [%]	x [µm]
5	2.8
10	3.1
25	3.7
50	4.5
75	5.5
90	6.5
95	7.1
99	8.2